

# ST1G3234

### 1-bit dual supply bus buffer level translator with A-side series resistor

### Features

- High speed: t<sub>PD</sub> = 4.4ns (Max.) at T<sub>A</sub> = 85°C V<sub>CCB</sub> = 1.65V; V<sub>CCA</sub> = 3.0V
- Low power dissipation:  $I_{CCA} = I_{CCB} = 5\mu A(Max.) \text{ at } T_A = 85^{\circ}C$
- Symmetrical output impedance:  $II_{OHA}I = I_{OLA} = 10$ mA Min at  $V_{CCA} = 2.75$ V;  $V_{CCB} = 1.4$ V to 3.6V  $II_{OHA}I = I_{OLA} = 6$ mA Min at  $V_{CCA} = 2.3$ V;  $V_{CCB} = 1.4$ V to 3.6V
- Balanced propagation delays: t<sub>PLH</sub> ≅ t<sub>PHL</sub>
- Power down protection on inputs and outputs
- 26Ω series resistor on A-side outputs
  - Operating voltage range: V<sub>CCA</sub>(Opr) = 1.4V to 3.6V (1.2V data retent) V<sub>CCB</sub>(Opr) = 1.4V to 3.6V (1.2V data retent)
- Max data rates: 380Mbps (1.8V to 3.3V translation) 260Mbps (<1.8V to 3.3V translation) 260Mbps (translate to 2.5V) 210Mbps (translate to 1.5V)
- Latch-up performance exceeds 500mA (JESD 17)
- ESD performance: HBM > 2000V (MIL STD 883 method 3015); MM > 200V
- R<sub>O</sub>HS compliant for Flip-Chip package



### Description

The ST1G3234 is a dual supply low voltage CMOS 1-Bit bus buffer level translator fabricated with sub-micron silicon gate and five-layer metal wiring C<sup>2</sup>MOS technology. Designed for use as an interface between a 3.3V bus and a 2.5V or 1.8V bus in a mixed 3.3V/1.8V, 3.3V/2.5V, 1.8V/1.4V and 2.5V/1.8V supply systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

This IC is intended for one-way asynchronous communication between data buses. The input and output power down protections disable the device when both power supply are down, so that the buses are effectively isolated.

The input tolerant buffers allow to translate  $V_{CCB}$  compatible signals and greater signals than  $V_{CCB}$  up/down to  $V_{CCA}.$ 

All inputs are equipped with protection circuits against static discharge, giving them ESD immunity and transient excess voltage.

### Order codes

Part number	Package	Comments
ST1G3234BJR	Flip-Chip 5	4000 parts per reel

August 2006

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## 1 Pin settings

### 1.1 Pin connection

#### Figure 1. Pin connection (top through view)



### 1.2 Pin description

### Table 1. Pin description

Pin N°	Symbol	Name and function
A1	A1	Data output (V <sub>CCA</sub> referred)
C1	B1	Data input (V <sub>CCB</sub> referred)
B2	GND	Ground (0V)
A3	V <sub>CCA</sub>	Positive supply voltage
C3	V <sub>CCB</sub>	Positive supply voltage



### 2 Device summary





#### Figure 3. Logic diagram



#### Table 2. Truth table

Inputs B1 (V <sub>CCB</sub> Referred)	Outputs A1 (V <sub>CCA</sub> Referred)
L	L
Н	н



### 3 Maximum rating

Stressing the device above the rating listed in the "Absolute Maximum Ratings" table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Symbol	Parameter	Value	Unit
V <sub>CCA</sub>	Output supply voltage	-0.5 to +4.6	V
V <sub>CCB</sub>	Input supply voltage	-0.5 to + 4.6	V
V <sub>OA</sub>	DC output voltage (power down mode: V <sub>CCA</sub> =V <sub>CCB</sub> =Gnd)	-0.5 to +4.6	v
V <sub>IB</sub>	DC input voltage (power down mode: V <sub>CCA</sub> =V <sub>CCB</sub> =Gnd)	-0.5 to +4.6	v
V <sub>OA</sub>	DC output voltage	-0.5 to V <sub>CCA</sub> + 0.5	V
V <sub>IB</sub>	DC input voltage	-0.5 to + 4.6	V
Ι <sub>ΙΚ</sub>	DC input diode current	-20	mA
I <sub>ОК</sub>	DC output diode current	-50	mA
I <sub>OA</sub>	DC output current	±50	mA
I <sub>CCA</sub>	DC V <sub>CCA</sub> or ground current	±100	mA
I <sub>CCB</sub>	DC V <sub>CCB</sub> or ground current	±100	mA
Pd	Power dissipation	200	mW
T <sub>stg</sub>	Storage temperature	-65 to +150	°C
ΤL	Lead temperature (10 sec)	260	°C

#### Table 3. Absolute maximum ratings



### 3.1 Recommended operating conditions

Symbol	Parameter	Value	Unit	
V <sub>CCA</sub>	Supply voltage		1.4 to 3.6	V
V <sub>CCB</sub>	Supply voltage		1.4 to 3.6	V
V <sub>IB</sub>	Input voltage (B1)	0 to V <sub>CCB</sub>	V	
V <sub>OA</sub>	Output voltage (A1)	0 to V <sub>CCA</sub>	V	
T <sub>op</sub>	Operating temperature		-40 to 85	°C
		V <sub>CCB</sub> = 3.0 to 3.6V	0 to 10	ns/V
dt/dv	Input Rise and Fall Time <sup>(1)</sup>	$V_{CCB} = 2.3 \text{ to } 2.7 \text{V}$	0 to 20	ns/V
	V <sub>CCB</sub> = 1.4 to 1		0 to 100	ns/V

1. VI from 0.8V to 2.0V at V<sub>CC</sub> = 3.0V



## 4 Electrical characteristics

#### Table 5. DC specification

			Test condition			Value					
Symbol	Parameter	V <sub>CCB</sub>	V <sub>CCA</sub>		T <sub>A</sub> =	25 °C	-40 to	85 °C	Unit		
		(V) <sup>(1)</sup>	<b>(V)</b> <sup>(1)</sup>		Min	Max	Min	Max			
		1.4			$0.65 V_{CCB}$		$0.65V_{CCB}$				
V <sub>IHB</sub>	High level input	1.8	1.4 to		$0.65V_{CCB}$		$0.65V_{CCB}$		v		
IHB	voltage	2.5	3.6V		1.6		1.6		v		
		3.3			2.0		2.0				
		1.4				$0.35V_{CCB}$		$0.35V_{CCB}$			
V <sub>ILB</sub>	Low level input	1.8	1.4 to			$0.35V_{CCB}$		$0.35V_{CCB}$	v		
' ILD	voltage	2.5	3.6V			0.7		0.7			
		3.3				0.8		0.8			
			1.4	Ι <sub>Ο</sub> =-100μΑ	1.2		1.2				
			2.75	I <sub>O</sub> =-10mA	2.2		2.2		v		
V <sub>OHA</sub>	High level output voltage	1.4 to e 3.6V	2.3	I <sub>O</sub> =-6mA	1.8		1.8		v		
			1.65	I <sub>O</sub> =-2mA	1.4		1.4				
			1.4	I <sub>O</sub> =-1mA	1.1		1.1				
			1.4	Ι <sub>Ο</sub> =100μΑ		0.20		0.20			
			2.75	I <sub>O</sub> =1mA		0.40		0.40			
V	Low level output	1.4 to	2.75	I <sub>O</sub> =10mA		0.55		0.55	v		
V <sub>OLA</sub>	voltage	3.6V	2.3	I <sub>O</sub> =6mA		0.40		0.40	V		
			1.65	I <sub>O</sub> =2mA		0.25		0.25			
			1.4	I <sub>O</sub> =1mA		0.20		0.20			
	Input leakage	2.7	3.6	$V_{IB} = V_{CCB}$ or GND		±0.5		±5	μA		
I <sub>IB</sub>	current	1.4	2.7	V <sub>IB</sub> =3.6V or GND		±0.5		±5	μA		
I <sub>OFF</sub>	Power OFF leakage current	0	0	V <sub>IB</sub> =GND to 3.6V V <sub>OA</sub> =GND to 3.6V		±1.0		±10	μA		
I <sub>CCtB</sub>	Quiescent supply current	1.4 to 3.6V	1.4 to 3.6V	$V_{IB} = V_{CCB}$ or GND		0.5		5	μA		
I <sub>CCtA</sub>	Quiescent supply current	1.4 to 3.6V	1.4 to 3.6V	$V_{IB} = V_{CCB}$ or GND		0.5		5	μA		

1.  $V_{CC}$  range = 3.3 ± 0.3; 2.5 ± 0.2V; 1.8 ± 0.15V



		Test condition			Va		
Symbol	Parameter	V <sub>CCB</sub> V <sub>CCA</sub>			-40 to 85 °C		Unit
		(V)	(V)		Min	Max	
		2.3 to 3.6	1.4		2.0	5.0	
		1.4 to 1.95	1.4		2.0	5.0	
		2.3 to 3.6	1.65 to 1.95		2.0	4.5	
t <sub>PLH</sub> t <sub>PHL</sub>	t <sub>PHL</sub> Propagation delay time B1 to A1	1.4 to 1.95	1.65 to 1.95	C <sub>L</sub> = 10 pF	2.0	4.8	ns
		1.4 to 1.95	2.3 to 2.7		2.0	3.5	
		1.4 to 1.95	3.0 to 3.6		2.0	3.5	
		2.3 to 2.7	3.0 to 3.6		1.0	3.0	
		2.3 to 3.6	1.4		2.0	5.5	
	Propagation delay time B1 to A1	1.4 to 1.95	1.4	C <sub>L</sub> = 30 pF R <sub>L</sub> = 500 Ω	2.0	5.5	ns
		2.3 to 3.6	1.65 to 1.95		2.0	5.0	
t <sub>PLH</sub> t <sub>PHL</sub>		1.4 to 1.95	1.65 to 1.95		2.0	5.2	
		1.4 to 1.95	2.3 to 2.7		2.0	4.0	
		1.4 to 1.95	3.0 to 3.6		2.0	4.0	
		2.3 to 2.7	3.0 to 3.6		1.0	3.5	

#### Table 7. Capacitance characteristics

			Tes	Test condition		Value							
Symbol	Parameter	V <sub>CCB</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>		T,	<sub>Δ</sub> = 25 ΄	°C	-40 to	85 °C	Unit
		(V)	(V)		Min	Тур	Max	Min	Max				
C <sub>INB</sub>	Input capacitance	open	open			5				pF			
Co	Output capacitance	2.5	3.3			6				pF			
		2.5	3.3			27							
		1.8	3.3			27							
C <sub>PD</sub>	Power dissipation capacitance	1.4	2.5	f = 10MHz		23				pF			
		1.4	1.8			20							
		3.3	1.8			27							

Note: 1  $C_{PD}$  is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit). Average current can be obtained by the following equation.  $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}/4$  (per circuit)

## 5 Test circuit





#### Table 8. Test circuit

Test	Switch
t <sub>PLH</sub> , t <sub>PHL</sub>	Open

 $C_L = 10/30 pF$  or equivalent (includes jig and probe capacitance)

 $R_L = R_1 = 500 \Omega$  or equivalent

 $R_T = Z_{OUT}$  of pulse generator (typically 50 $\Omega$ )



## 6 Waveforms

#### Table 9. Waveform symbol value

Symbol	V <sub>CC</sub>				
	3.0 to 3.6V	2.3 to 2.7V	1.65 to 1.95V		
V <sub>IH</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>		
V <sub>M</sub>	1.5V	V <sub>CC</sub> /2	V <sub>CC</sub> /2		
V <sub>X</sub>	V <sub>OL</sub> +0.3V	V <sub>OL</sub> +0.15V	V <sub>OL</sub> +0.15V		
V <sub>Y</sub>	V <sub>OL</sub> -0.3V	V <sub>OL</sub> -0.15V	V <sub>OL</sub> -0.15V		

### Figure 5. Waveform - propagation delay (f = 1MHz; 50% duty cycle)





### 7 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com





Note:

X = Marking Area; Marking Code 9537



	Flip-Chip 5 MECHANICAL DATA					
DIM.	mm.			mils		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	0.585	0.65	0.715	23.0	25.6	28.1
A1	0.21	0.25	0.29	8.3	9.8	11.4
a2		0.40			15.7	
b	0.265	0.315	0.365	10.4	12.4	14.4
D	1.31	1.36	1.41	51.6	53.5	55.5
D1		0.866			34.1	
Е	0.97	1.02	1.07	38.2	40.2	42.1
E1		0.5			19.7	
eD	0.383	0.433	0.483	15.1	17.0	19.0
еE	0.20	0.25	0.30	7.9	9.8	11.8
fD		0.247			9.7	
fE		0.260			10.2	
ccc		0.080			3.1	





	Tape & Reel Flip-Chip 5 MECHANICAL DATA					
DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А			178			6.926
С	12.8		13.2	0.504		0.519
D	20.2			0.795		
Ν	49	50	51	1.929	1.969	2.008
Т			12.4			0.488
Ao	1.60	1.65	1.70	0.063	0.065	0.067
Во	1.27	1.32	1.37	0.050	0.052	0.054
Ko	0.76	0.81	0.86	0.030	0.032	0.034
Po	3.9	4	4.1	0.153	0.157	0.161
Р	3.9	4	4.1	0.153	0.157	0.161





## 8 Revision history

#### Table 10. Revision history

Date	Revision	Changes	
14-Oct-2004	1	First release.	
20-Dec-2004	2	Revision on Table 3.	
11-Feb-2005	3	Add Tape & Reel, Figures 2, 3, 5, 6, <i>Table 3</i> , <i>5</i> , <i>7</i> and Mechanical Data has been modified.	
30-Mar-2005	4	Add features ==> Max data rates.	
09-May-2005	5	Table 7 and Table 8 have been updated.	
16-Aug-2006	6	New template, updated test condition V <sub>OHA</sub> Table 5	



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